HHW microSD Card

SD3.0 UHS-I

Datasheet

Rev. 1.0

Revision History

Revision	Description	Date
V1.1	First released	August, 2015
V1.2	Updated humidity information	March, 2017
V1.3	Part number updated	September, 2018

1. Product Introduction

1.1. Overview

The microSD Card is designed for demanding industrial applications. The microSD Card is compatible with SD 3.0 and provides excellent performance. The built-in auto ECC function can detect and correct errors during data transfer. Moreover, the Industrial microSD Card supports Ultra High Speed (UHS) interface transfer mode, provides high write/read data transfer rate, sudden Power-Fails protection, adaptive static wear-leveling, read/program disturb management, etc. It was designed to meet the high quality, high reliability, high performance, and versatile environmental requirements.

1.2. Product Features

- Interface: 8 pins microSD standard interface
- Compliant SD Card Specification 3.0
- Density support:
  - 32GB、64GB、128GB
- Bus Speed Mode:
  - DS-Default Speed mode: 3.3V signaling, frequency up to 25MHz, up to 12.5MB/sec
  - HS-High Speed mode: 3.3V signaling, frequency up to 50MHz, up to 25MB/sec
  - SDR12: 1.8V signaling, frequency up to 25MHz, up to 12.5MB/sec
  - SDR25: 1.8V signaling, frequency up to 50MHz, up to 25MB/sec
  - SDR50: 1.8V signaling, frequency up to 100MHz, up to 50MB/sec
  - SDR104: 1.8V signaling, frequency up to 208MHz, up to 104MB/sec

- DDR50: 1.8V signaling, frequency up to 50MHz, sampled on both clock edges, up to 50MB/s

- Operating Temperature: -25°C to 85°C
- Flash: YMTC NAND Flash
- 32GB Speed Class : Class 10、A2、U1、V10
- 64-128GB Speed Class : Class 10、A2、U3、V30
- ECC Correction
- Bad Block Management

2. microSD Card Interface Description

2.1 microSD Pin Assignment

Table 1: microSD Bus Mode Pin Definition

Pin #	Name	Type	microSD Description
1	DAT2	I/O	Data Line [Bit 2]
2	CD/DAT3	I/O	Card Detect / Data Line[Bit3]
3	CMD	PP	Command / Response
4	VDD	S	Supply Voltage
5	CLK	I	Clock
6	VSS	S	Supply Voltage Ground
7	DAT0	I/O	Data Line [Bit 0]
8	DAT1	I/O	Data Line [Bit 1]

Notes:

1) S: power supply; I: input; O: output using push-pull drivers; PP: I/O using push-pull drivers;
2) The extended DAT Lines (DAT1-DAT3) are input on power up. They start to operate as DAT lines after SET_BUS_WIDTH command. The Host shall keep its own DAT1-DAT3 lines in input mode, as well, while they are not used. It is defined so, in order to keep compatibility to Multi-media Cards.
3) After power up this line (Pin2) is input with 50Kohm pull-up (can be used for card detection or SPI mode selection). The pull-up should be disconnected by user, during regular data transfer, with SET_CLR_CARD_DETECT (ACMD42) command.

Table 2: SPI Bus Mode Pin Definition

Pin #	Name	Type	microSD Description
1	RSV		Reserved
2	CS	I	Chip Select (neg true)
3	DI	I	Data In
4	VDD	S	Supply Voltage
5	SCLK	I	Clock
6	VSS	S	Supply Voltage Ground
7	DO	O	Data Out

8	RSV		Reserved

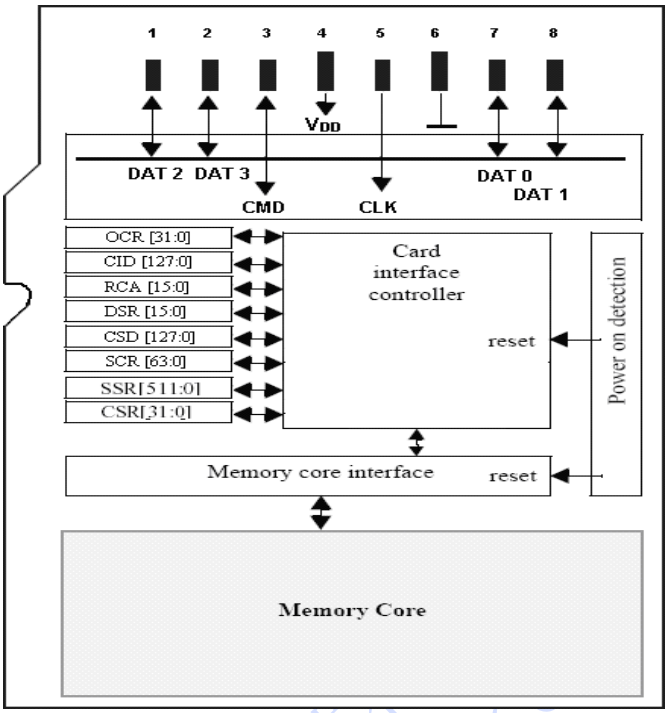

Figure 1: Functional Diagram

3. Specifications

3.1. Performance

Min. Data Transfer Rate

- V10 Write: 10MB/s
- V30 Write: 30MB/s

3.2. NAND Flash Memory

microSD Card (TLC) NAND Flash memory, which is non-volatility, high reliability and high speed memory storage.

3.3. Power Requirement

3.3.1. DC Input Voltage

- 2.7V to 3.6V

3.4. Operature Temperature Range

- -25°C to+85°C

3.5. Humidity

Relative Humidity: 5-95%, non-condensing

4. Electrical Specifications

4.1. General DC Characteristic

W-Temp **Table 3: Absolute Maximum Ratings**

Symbol	Parameter	Min.	Max.	Unit	Note
$T_{storage}$	Storage Temperature	-40	85	°C	-
Ta	Ambient Operating Temperature	0	85	°C	-
V_I	3.3V External Input Voltage	-0.3	3.6	V	-

N-Temp

Symbol	Parameter	Min.	Max.	Unit	Note
$T_{storage}$	Storage Temperature	-40	85	°C	-
Ta	Ambient Operating Temperature	0	85	°C	-

V_I	3.3V External Input Voltage	-0.3	3.6	V	-

Table 4: Power Consumption

Symbol	Parameter	Min.	Typ.	Max.	Unit
I_{Read}	Read Current at 3.3V	-	125	-	mA
I_{Write}	Write Current at 3.3V	-	186	-	mA
I_{STBY}	Standby Current at 3.3V	-	213	-	uA

4.2. Bus Operation Conditions for 3.3V Signaling

4.2.1 Threshold Level for High Voltage Range

Table 5: Threshold Level for High Voltage

Parameter	Symbol	Min	Max	Unit	Remark
Supply Voltage	V_{DD}	2.7	3.6	V	
Output High Voltage	V_{OH}	0.75* V_{DD}		V	I_{OH}=2mA $V_{DD\ min}$
Output Low Voltage	V_{OL}		0.125* V_{DD}	V	I_{OL}=2mA $V_{DD\ min}$
Input High Voltage	V_{IH}	0.625* V_{DD}	V_{DD}+0.3	V	
Input Low Voltage	V_{IL}	V_{ss}-0.3	0.25* V_{DD}	V	
Power Up Time			250	ms	From 0V to $V_{DD\ min}$

4.2.2 Peak Voltage and Leakage Current

Table 6: Peak Voltage and Leakage Current

Parameter	Symbol	Min	Max	Unit	Remark
Peak voltage on all lines		-0.3	V_{DD}+0.3	V	
All Inputs					
Input Leakage Current		-10	10	uA	
All Outputs					
Output Leakage Current		-10	10	uA	

4.2.3 Bus Signal Line Load

Table 7: Bus Operating Conditions - Signal Line's Load

Parameter	Symbol	Min	Max	Unit	Remark
Pull-up resistance	R_{CMD} R_{DAT}	10	100	KΩ	To prevent bus floating
Total bus capacitance for each signal line	C_L		40	pF	1 card C_{HOST}+C_{BUS} shall not exceed 30pF
Card capacitance for each signal pin	C_{CARD}		10	pF	
Maximum signal inductance			16	nH	
Pull-up resistance inside card(pin1)	R_{DAT3}	10	90	KΩ	May be used for card detection
Capacity Connected to Power Line	C_C		5	uF	To prevent inrush current

4.2.4 Bus Signal Levels

As the bus can be supplied with a variable supply voltage, all signal levels are related to the supply voltage.

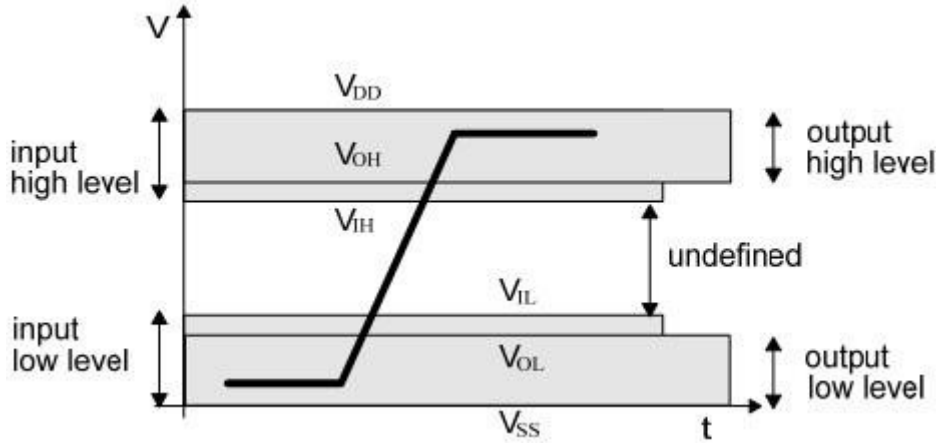

Figure 2: Bus Signal Levels

To meet the requirements of the JEDEC specification JESD8-1A and JESD8-7,the card input and output voltages shall be within the specified ranges shown in Table 6 for any VDD of the allowed voltage range.

4.2.5 Bus Timing (Default)

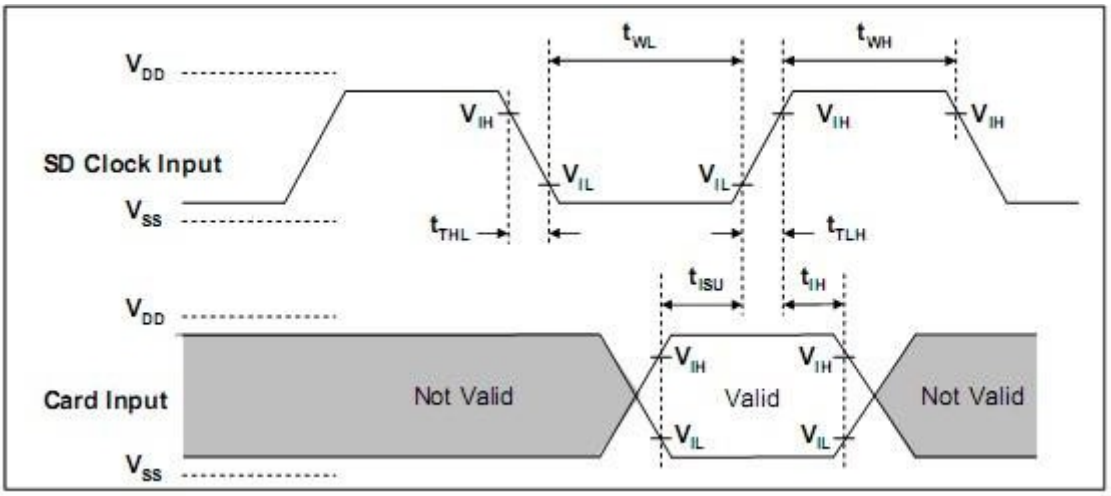

Figure 3: Card input Timing (Default Speed Card)

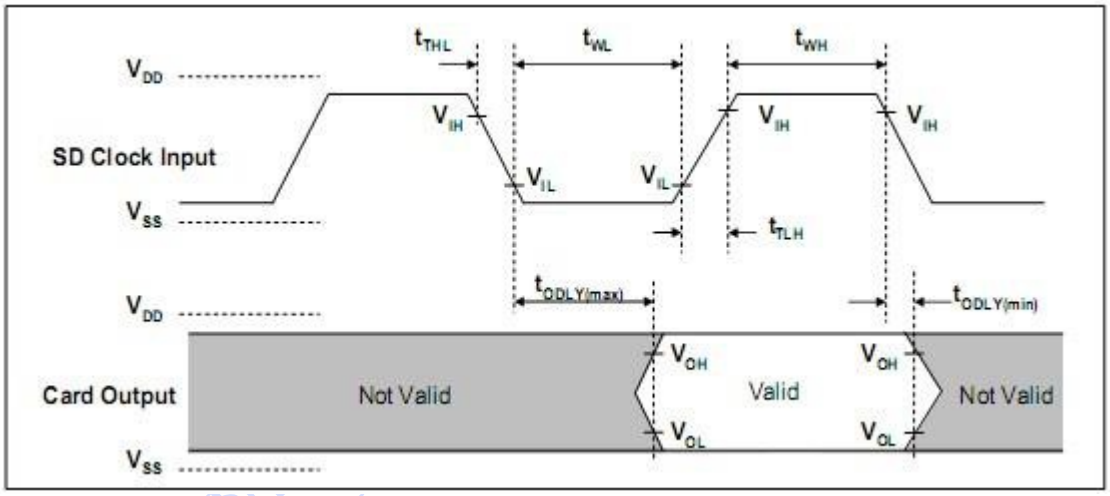

Figure 4: Card Output Timing (Default Speed Mode) Table 8: Bus Timing-Parameters Values

Parameter (Default Speed)	Symbol	Min.	Max	Unit	Remark
Clock CLK (All values are referred to min (V_{IH}) and max (V_{IL})					
Clock frequency data transfer	fpp	0	25	MHz	C_{CARD} ≤ 10pF (1 card)
Clock frequency Identification	f_{OD}	0[(1)]/100	400	KHz	C_{CARD} ≤ 10pF (1 card)
Clock low time	t_{WL}	10		ns	C_{CARD} ≤ 10pF (1 card)
Clock high time	t_{WH}	10		ns	C_{CARD} ≤ 10pF (1 card)
Clock rise time	t_{TLH}		10	ns	C_{CARD} ≤ 10pF (1 card)
Clock fall time	t_{THL}		10	ns	C_{CARD} ≤ 10pF (1 card)
Inputs CMD, DAT (referenced to CLK)					
Input set-up time	t_{ISU}	5		ns	C_{CARD} ≤ 10pF (1 card)

Input hold time	t_{TH}	5		ns	C_{CARD} ≤ 10pF (1 card)
Outputs CMD, DAT (referenced to CLK)					
Output Delay time during Data Transfer Mode	t_{ODLY}	0	14	ns	C_L ≤ 40pF (1 card)
Output Hold time	t_{OH}	0	50	ns	C_L ≤ 40pF (1 card)

(1) 0 Hz means to stop the clock. The given minimum frequency range is for cases were continues clock is required (refer to Chapter 4.4-Clock Control)

4.2.6 Bus Timing (High-Speed Mode)

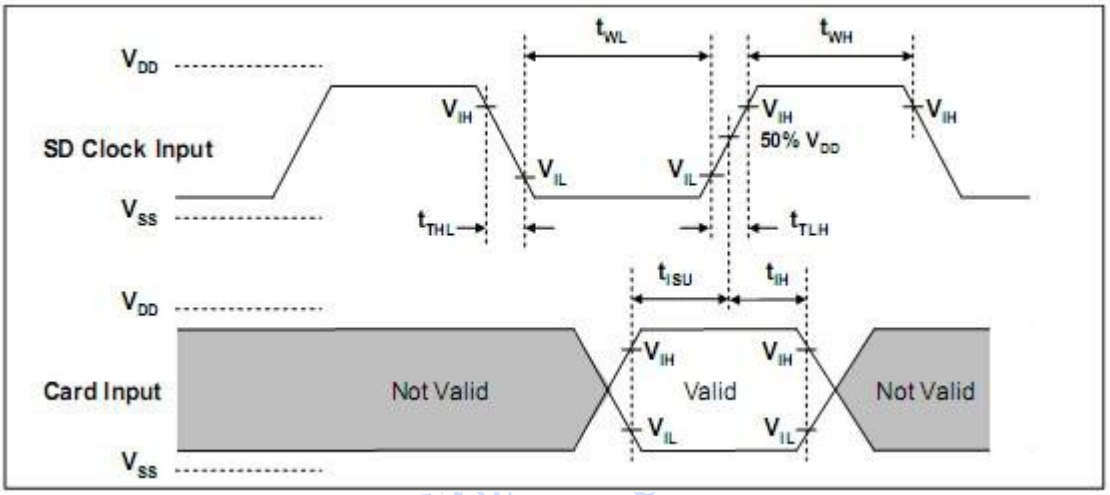

Figure 5: Card Input Timing (High Speed Card)

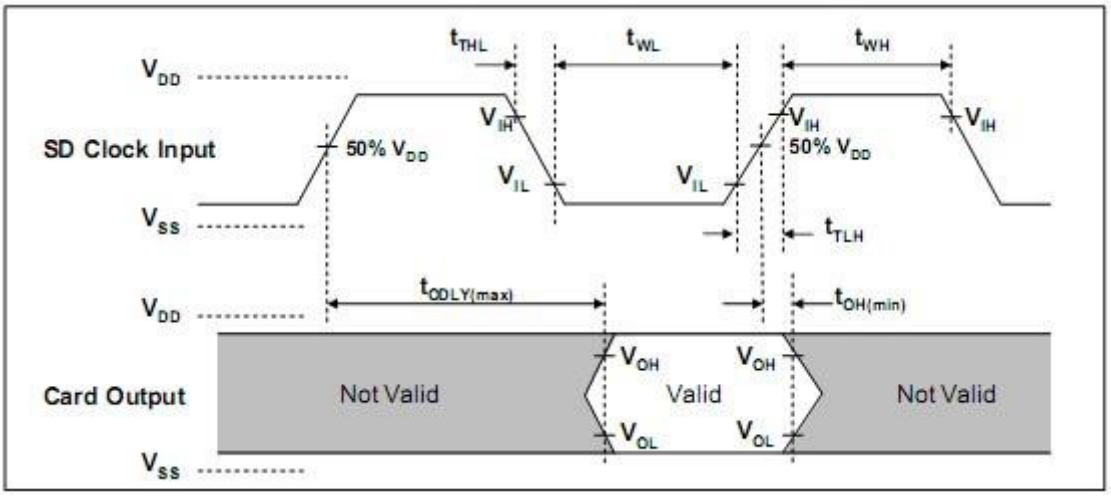

Figure6: Card Output Timing (High Speed Mode)

Table 9 : Bus Timing – Parameters Values(High Speed)

Parameter	Symbol	Min.	Max	Unit	Remark
Clock CLK (All values are referred to min (V_{IH}) and max (V_{IL})					
Clock frequency data transfer	fpp	0	50	MHz	C_{CARD} ≤ 10pF (1 card)
Clock low time	t_{WL}	7		ns	C_{CARD} ≤ 10pF (1 card)
Clock high time	t_{WH}	7		ns	C_{CARD} ≤ 10pF (1 card)
Clock rise time	t_{TLH}		3	ns	C_{CARD} ≤ 10pF (1 card)
Clock fall time	t_{THL}		3	ns	C_{CARD} ≤ 10pF (1 card)
Inputs CMD, DAT (referenced to CLK)					
Input set-up time	t_{ISU}	6		ns	C_{CARD} ≤ 10pF (1 card)
Input hold time	t_{TH}	2		ns	C_{CARD} ≤ 10pF (1 card)
Outputs CMD, DAT (referenced to CLK)					
Output Delay time during Data Transfer Mode	t_{ODLY}		14	ns	C_L ≤ 40pF (1 card)
Output Hold time	t_{OH}	2.5		ns	C_L ≥ 15pF (1 card)
Total System capacitance for each line[1]	C_L		40	pF	1 card

1) In order to satisfy sever timing, host shall drive only one card.

4.3 Bus Operation Conditions for 1.8V Signaling

4.3.1 Threshold Level for High Voltage Range

Table 10: Threshold Level for High Voltage

Parameter	Symbol	Min	Max	Unit	Remark
Supply Voltage	V_{DD}	2.7	3.6	V	
Regulator Voltage	V_{DDIO}	1.7	1.95	V	Generated by V_{DD}
Output High Voltage	V_{OH}	1.4		V	I_{OH}=2mA $V_{DD\ min}$
Output Low Voltage	V_{OL}		0.45	V	I_{OL}=2mA $V_{DD\ min}$
Input High Voltage	V_{IH}	1.27	2.0	V	
Input Low Voltage	V_{IL}	V_{ss}-0.3	0.58	V	

4.3.2 Peak Voltage and Leakage Current

Table 11: Peak Voltage and Leakage Current

Parameter	Symbol	Min	Max	Unit	Remark
Input Leakage Current		-2	2	uA	DAT3 pull-up is disconnected

4.3.3 Bus Timing Specification in SDR12, SDR25, SDR50 and SDR104 Modes

4.3.3.1 Clock Timing

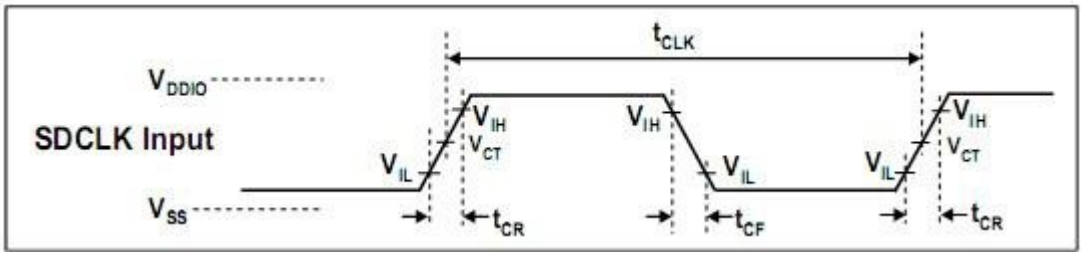

Figure 7: Clock Signal

Timing Table 12: Clock

Symbol	Min	Max	Unit	Remark
t_{CLK}	4.8	-	ns	208MHz (Max.), Between rising edge, V_{CT}=0.975V
t_{CR}, t_{CF}	-	0.2* t_{CLK}	ns	t_{CR}, t_{CF} < 2.00ns (max.) at 208MHz, C_{CARD}=10pF t_{CR}, t_{CF} < 2.00ns (max.) at 100MHz, C_{CARD}=10pF The absolute maximum value of t_{CR}, t_{CF} is 10ns regardless of clock frequency
Clock Duty	30	70	%	

Signal Timing

4.3.3.2 Card Input Timing

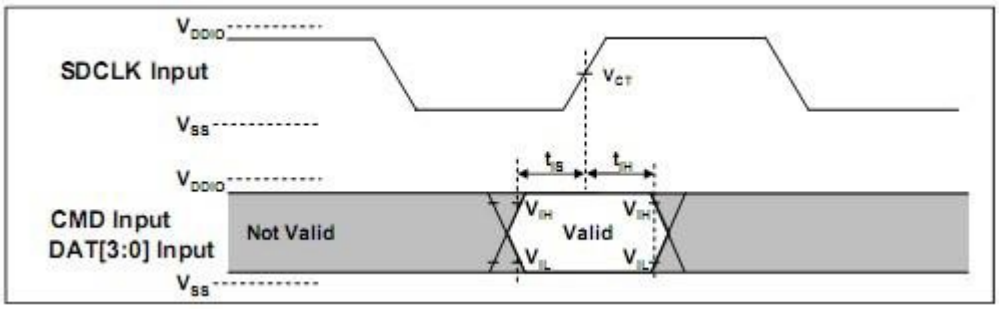

Figure 8: Card Input Timing

Table 13: SDR50 and SDR104 Input Timing

Symbol	Min	Max	Unit	SDR104 mode
t_{IS}	1.40	-	ns	C_{CARD} = 10pF, V_{CT} = 0.975V
t_{IH}	0.80		ns	C_{CARD} = 5pF, V_{CT} = 0.975V
Symbol	Min	Max	Unit	SDR12, SDR25 and SDR50 modes
t_{IS}	3.00	-	ns	C_{CARD} = 10pF, V_{CT} = 0.975V
t_{IH}	0.80	-	ns	C_{CARD} = 5pF, V_{CT} = 0.975V

4.3.3.3 Card Output Timing

4.3.3.3.1 Output Timing of Fixed Data Window (SDR12, SDR25 and SDR50)

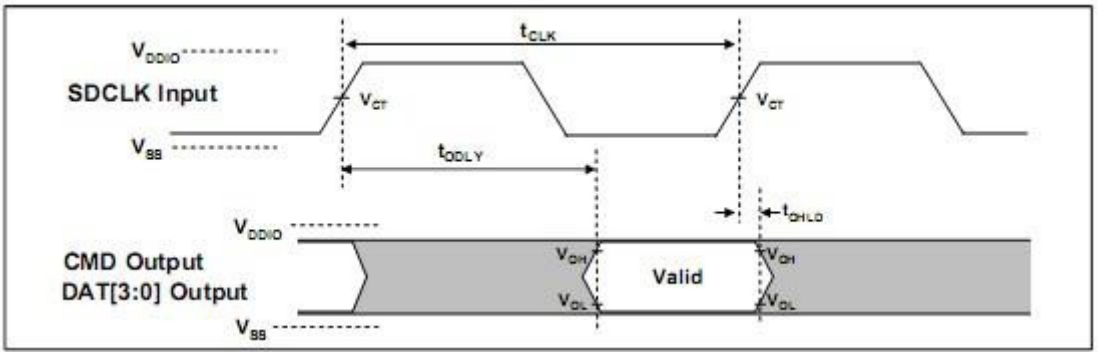

Figure 9: Output Timing of Fixed Date

Window Table 14: Output Timing of Fixed

Data Window

Symbol	Min	Max	Unit	Remark
t_{ODLY}	-	7.5	ns	t_{CLK} ≥10.0ns, CL=30pF, using driver Type B, for SDR50.
t_{ODLY}		14	ns	t_{CLK} ≥20.0ns, CL=40pF, using driver Type B, for SDR25 and SDR12.
t_{OH}	1.5	-	ns	Hold time at the t_{ODLY} (min.). CL=15pF

4.3.3.3.2 Output Timing of Variable Window (SDR104)

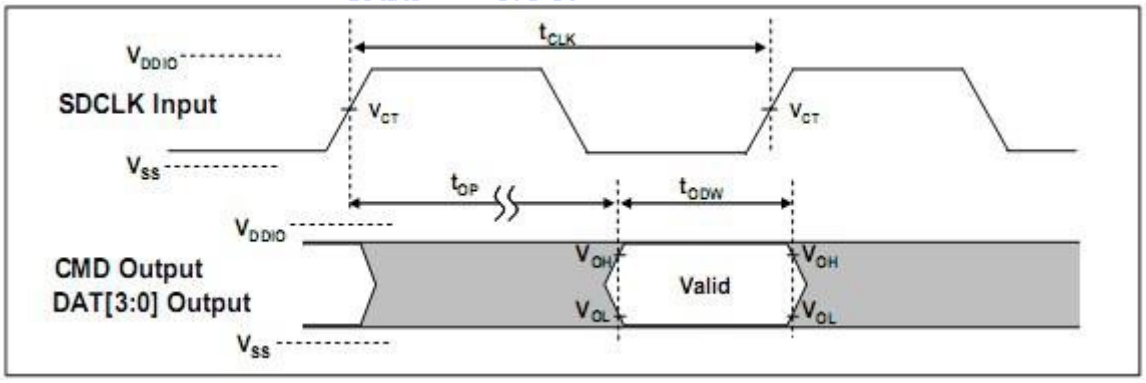

Figure 10: Output Timing of Variable Data

Symbol	Min	Max	Unit	Remark
t_{OP}	-	2	UI	Card Output Phase
$\triangle t_{OP}$	-350	+350	ps	Delay variation due to temperature change after tuning
t_{ODW}	0.60	-	UI	t_{ODW} = 2.88ns at 208MHz

Window Table 15: Output Timing of Variable

Data Window

5. Mechanical Dimensions

The mechanical dimensions of Agrade Industrial microSD Card were basically followed the mechanical form factor definitions on microSD card specifications which constructed by SD card association.

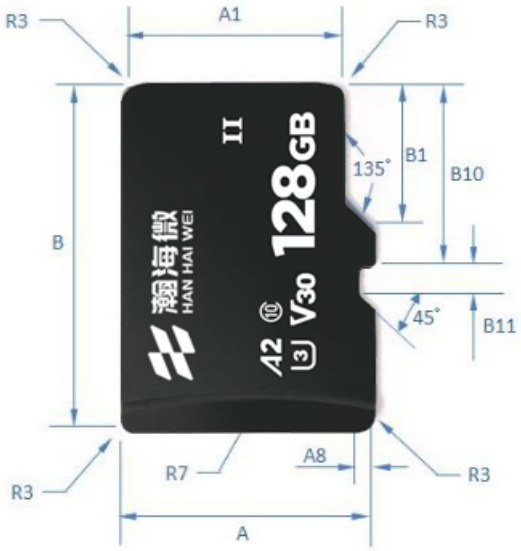

Figure 11: Top View

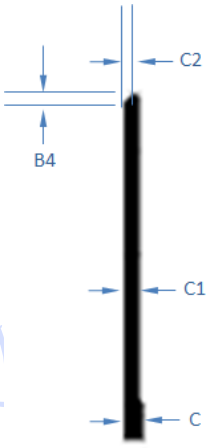

Figure 12: Side View

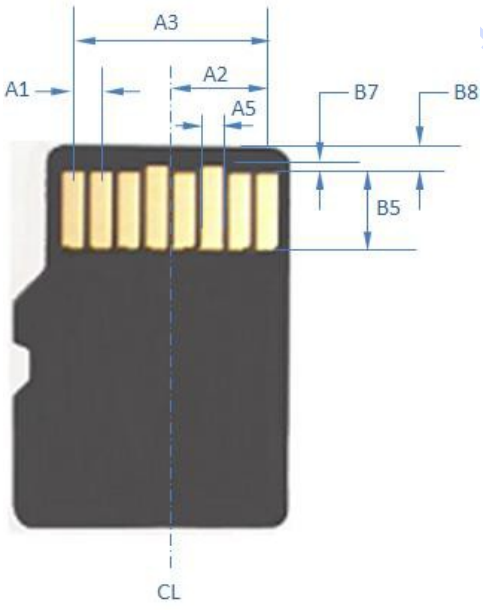

Figure 13: Bottom View

Criteria of microSD Unit: mm

Dimensions	Min	TYP	Max	Note
A	10.90	11.00	11.10	
A1	9.60	9.70	9.80	
A2		3.85		BASIC
A3	7.60	7.70	7.80	
A4		1.10		BASIC
A5	0.75	0.80	0.85	
A8	0.60	0.70	0.80	
B	14.90	15.00	15.10	
B1	6.13	6.23	6.33	
B4	0.42	0.52	0.62	
B5	2.80	2.90	3.00	
B7	0.20	0.30	0.40	
B8	1.00	1.10	1.20	
B10	7.80	7.90	8.00	
B11	1.10	1.20	1.30	
R3	0.70	0.80	0.90	
R7	29.50	30.00	30.50	
C	0.90	1.00	1.10	
C1	0.60	0.70	0.80	
C2	0.20	0.30	0.40	

6. Ordering Information

	microSD Card(MLC)	microSD Card(SLC)
Capacity	Normal-temperature	Wide-temperature
4GB		
8GB		
16GB		
32GB		

MicroSD Card(TLC)			
Capacity	Normal-Temperature	Extended-Temperature	Wide-temperature
4GB			
8GB			
16GB			
32GB		HHW32GTFT-BCA2	
64GB		HHW64GTFT-BCA2	
128GB		HHW128GTFT-BCA2	